Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/620,772	KAHN ET AL.	
Examiner	Art Unit	
Ellen C. Tran	2134	

SEARCHED					
Class	Subclass	Date	Examiner		
380	201	7/20/2007	ET		
380	277	7/20/2007	ET		
380	278	7/20/2007	ET		
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			· 12 th/to		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	.				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	7/20/2007	ET	
NPL - IEEE XPLORE	7/20/2007	ET	
ALL CLAIMS WERE REVIEWED FOR POSSIBLE 101 REJECTIONS	7/20/2007	ET	